Complex Permittivity Measurement of Low-Loss Anisotropic Dielectric Materials at Hundreds of Megahertz

Chuanlan Li 1, Changying Wu 2,* and Lifei Shen 1

1 AVIC Research Institute for Special Structures of Aeronautical Composites, Jinan 250031, China; yinchengkun6@163.com (C.L.); shen15529671003@163.com (L.S.)
2 School of Electronics and Information, Northwestern Polytechnical University, Xi’an 710129, China
* Correspondence: aaawucy@nwpu.edu.cn

Abstract: Resonant methods are well known for their accuracy in determining the complex permittivity of materials. However, to guarantee the accuracy, interference modes must be suppressed in the measurement band. In this paper, a multi-mode split rectangular cavity is designed and fabricated to measure low-loss anisotropic dielectric materials in the frequency range from 300 to 1000 MHz. Details of the cavity design are presented. Simulation results for a uniaxially anisotropic material validate both the setup and the processing. Moreover, validation measurements on a sheet of polytetrafluoroethylene (PTFE) are in agreement with the literature data, which indicate that the proposed method in this paper is reliable and accurate for low-loss complex permittivity characterization at hundreds of megahertz.

Keywords: complex permittivity; anisotropic dielectric material; multi-mode; split rectangular cavity; hundreds of megahertz

1. Introduction

Measurement of electromagnetic parameters of materials, such as relative complex permittivity, is important in understanding their behavior in response to applied electromagnetic fields [1]. The knowledge of the complex permittivity values of materials is a prerequisite step for many types of electromagnetic applications. A wide variety of high-frequency methods for measuring the permittivity and loss tangent of dielectric materials is described in the literature. The methods are divided into two categories: non-resonant and resonant [2,3].

Non-resonant methods are mostly based on measurements of transmitted and/or reflected electromagnetic power from a sample under test illuminated by a well-determined incident electromagnetic wave. Methods using transmission-line approaches have been developed using a coaxal cell [4,5], a rectangular waveguide [6–8], a partially filled waveguide [9–11], a coplanar waveguide [12], or a flat sample in free space [13–17]. Determining complex permittivity from far-field scattering patterns is another type of non-resonant method [18,19].

Resonant-type methods measure electromagnetic parameters by using a change in resonant frequency and quality factor after the sample is inserted into the measurement cell. Generally speaking, resonance methods provide the best accuracy in the estimation of both real and imaginary parts of permittivity for low-loss dielectrics. The methods include different types of resonant cavities loaded with the material under test, such as $TE_{011}$ mode cylindrical cavity [20,21], $TM_{001}$ mode cylindrical cavity [22,23], rectangular cavity [24,25], Fabry–Perot resonator [26,27], etc. The sample under test can also create a dielectric resonator in the modes of $TE_{011}$ mode [28,29], $TE_{01d}$ mode [30,31], and whispering gallery mode [32,33], etc.
The complex permittivity of an isotropic material can be written as

$$\varepsilon = \varepsilon_0 \varepsilon_r = \varepsilon_0 \varepsilon'(1 - j \tan \delta)$$  (1)

where $\varepsilon_r$ is the relative complex permittivity, $\tan \delta$ is the loss tangent, and $\varepsilon_0 \approx 8.8542 \times 10^{-12}$ F/m denotes permittivity of the vacuum. In general, the permittivity of any linear material is defined as a tensor quantity that describes the relationship between the electric displacement $\mathbf{D}$ and the electric field $\mathbf{E}$ vectors

$$\mathbf{D} = \varepsilon \mathbf{E}$$  (2)

The permittivity tensor of uniaxially anisotropic materials can be written as

$$\varepsilon = \varepsilon_0 \begin{bmatrix} \varepsilon_r || & 0 & 0 \\ 0 & \varepsilon_r \perp & 0 \\ 0 & 0 & \varepsilon_r \perp \end{bmatrix}$$  (3)

where $||$ and $\perp$ represent the parallel and perpendicular components, respectively.

If samples under test are anisotropic, they must be oriented and cut with respect to their anisotropy axis. Some ingenious methods have been developed to measure the permittivity tensor of anisotropic materials. These methods also fall into non-resonant methods and resonant methods. Non-resonant methods for measuring the permittivity tensor of materials generally operate by placing a sample in a section of transmission line and measuring the two-port scattering parameters with the sample oriented parallelly and perpendicularly to the transverse electric field component of the propagating wave [34–37]. There are also some successful examples in the resonant methods to measure the permittivity tensor, such as the dielectric resonator method [38–40] and the dielectric-loaded metal cavity method [41–43].

The aim of this study is to present a technique to measure the complex permittivity of low-loss uniaxially anisotropic materials at hundreds of megahertz. Measurements on low-loss materials at GHz frequencies are typically performed in cylindrical cavities, whereas, at hundreds of megahertz, the large size of cylindrical cavities is a practical limitation. Therefore, it is possible to use rectangular cavities for they can be made of flat plates.

The remaining parts are organized as follows. In Section 2, a multi-mode rectangular cavity is designed for measuring uniaxially anisotropic materials at six frequencies from 300 MHz to 1000 MHz. In addition, a perturbation method and a rigorous iterative method are given to determine the complex permittivity. The simulation and the measurement results are provided in Sections 3 and 4, respectively. The last part, Section 5, concludes this work.

2. Theory
2.1. Rectangular Cavity Design

The geometry of a rectangular cavity is shown in Figure 1. It consists of a length $l$ of rectangular waveguide shorted at both ends. The side lengths of the cross section of the waveguide are $a$ and $b$. Under the assumption that the cavity is lossless, applying the condition that tangent electric vanishes on the conducting walls gives the resonant frequency of the TE$_{mnp}$ or TM$_{mnp}$ mode by

$$f_{mnp} = \frac{c}{2\pi} \sqrt{\left(\frac{m\pi}{a}\right)^2 + \left(\frac{n\pi}{b}\right)^2 + \left(\frac{p\pi}{l}\right)^2}$$  (4)

where the indices $m$, $n$, and $p$ refer to the number of variations in the standing wave pattern in the $x$, $y$, and $z$ directions.
In Figure 1, the $z$ axis is parallel with the side $l$. Therefore, the resonant frequency calculated by (1) is of $TE_{lmnp}^l$ or $TM_{lmnp}^l$ mode. If the $z$ axis is parallel with the side $a$ or $b$, there are four more groups of modes like $TE_{amnp}^a$, $TM_{amnp}^a$, $TE_{bmnp}^b$, and $TM_{bmnp}^b$. In this paper, to measure the tensor permittivity at several frequencies in a split rectangular cavity, six modes are employed, which are $TE_{l101}^l$, $TE_{l103}^l$, $TE_{l105}^l$, $TE_{l201}^l$, $TE_{l203}^l$, and $TE_{l205}^l$ modes. Since the second index $n$ is zero, the resonant frequencies of these modes are independent with the length of $b$. To make the six frequencies distribute from 300 MHz to 1000 MHz as evenly as possible, the $a$ and $l$ are chosen as

\begin{align*}
  a &= 488 \text{ mm} \\
  l &= 951 \text{ mm}
\end{align*} 

(5)

The resonant frequencies of six measurement modes are shown in Figure 2, as well as resonant frequencies below 1100 MHz of other modes calculated by (4). In Figure 2, $b$ is chosen the same as $a$. It can be seen in Figure 2 that there are excessive amounts of interference modes in the cavity, and many of them are degenerated. It is unpractical to distinguish the wanted modes from them.

Since the split rectangular cavity is used, there is a slot in the middle of the cavity, shown in Figure 3. Due to the fact that the modes with the electric current perpendicular to the slot are radiating, the resonant of these modes are negligible. They are $TE_{lmnp}^l$ and $TM_{lmnp}^l$ modes with even number $p$, $TE_{lmnp}^m$ modes with even number $m$, and $TM_{lmnp}^b$ and $TM_{lmnp}^b$ modes with even number $n$. 

![Figure 1. The geometry of a rectangular cavity.](image)

![Figure 2. All resonant frequencies of the rectangular cavity.](image)
Figure 3. The final rectangular cavity with many interference modes suppressed.

There are still a large number of interference modes left in the split rectangular cavity with a split in the middle. Extra work needs to be conducted to reduce the unwanted modes. If the feeding pins are at $x = a/3$, shown in Figure 3, due to the electric field distribution, more modes are suppressed. The suppressed modes are $\text{TE}^{l,mnp}$ and $\text{TM}^{l,mnp}$ modes with divisible-by-three $m$, $\text{TE}^{l,mnp}$ and $\text{TM}^{l,mnp}$ modes with divisible-by-three $p$, $\text{TM}^{b,mnp}$ modes with divisible-by-three $n$, and all $\text{TE}^{b,mnp}$ modes.

Four extra slots along $y$-axis are introduced at the corners of the cavity to suppress more modes. The modes with electric current perpendicular to these slots are prone to be radiated through these slots. As a result of that, a large number of modes are suppressed. They are $\text{TE}^{l,mnp}$ and $\text{TE}^{l,mnp}$ modes with greater-than-zero $n$, and all $\text{TM}^{l,mnp}$ and $\text{TM}^{l,mnp}$ modes.

With the above efforts, the only interference modes left are $\text{TM}^{b,mnp}$ modes with odd-number $n$, not-divisible-by-three $m$, and greater-than-0 $p$. If a small length of $b$ is chosen, all the resonant frequencies of the interference modes are outside the measurement band, while the resonant frequencies of the $\text{TE}^{10p}$ and $\text{TE}^{20p}$ modes do not change. However, small $b$ implies a low-quality factor. Therefore, $b$ is chosen so that some interference modes are in the measurement band but are far from the measurement modes. The chosen $b$ is

$$b = 309 \text{ mm}$$

Figure 4 shows the resonant frequencies of the measurement modes and interference modes of the cavity illustrated in Figure 3 with the size given by (5) and (6).

Figure 4. The measurement and interference resonant frequencies of the final rectangular cavity.
2.2. Complex Permittivity Determination by Perturbation Method

The total fields for the TE_{m0p} mode can be written as

\[ E_x = 0 \]
\[ E_y = \frac{\omega \mu_0 \pi}{k_c a} \sin \frac{m \pi x}{a} \sin \frac{p \pi z}{l} \]
\[ E_z = 0 \]
\[ H_x = -j \frac{\mu_0 \pi}{k_c a} \sin \frac{m \pi x}{a} \cos \frac{p \pi z}{l} \]
\[ H_y = 0 \]
\[ H_z = j \cos \frac{m \pi x}{a} \sin \frac{p \pi z}{l} \]

The power loss in the conducting walls is given as

\[ P_c = \frac{R_s}{2} \oint H_t^2 ds = \sqrt{\frac{\omega \mu_0}{2 \pi} \left( \frac{p^2 \pi^2 a^4 b}{2 l^2 k_c^4} + \frac{p^2 \pi^2 a^4}{4 k_c^4 l} + \frac{al}{4} + \frac{bl}{2} \right)} \]

where, \( R_s \) is the surface resistivity of the metallic walls, \( \sigma \) is the conductivity of the metallic walls, \( H_t \) is the tangential magnetic field at the surface of the walls, \( k_c = m \pi / a \) is the cutoff wavenumber.

The total stored energy is

\[ W = \varepsilon_0 \int_0^a \int_0^b \int_0^l |E_y|^2 dx dy dz = \frac{\varepsilon_0 \omega^2 \mu_0^2 \pi^2 a b l}{8 k_c^4 a} \]

Then, the conductor quality factor \( Q_c \) of the cavity with lossy conducting walls and lossless dielectric can be found as

\[ Q_c = \frac{\omega W}{P_c} = \frac{\varepsilon_0 \omega^3 \mu_0^2 \pi^2 a^2 b l}{8 R_s k_c^4 a \left( \frac{p^2 \pi^4 a^4 b}{2 l^2 k_c^4} + \frac{p^2 \pi^4 a^4}{4 k_c^4 l} + \frac{al}{4} + \frac{bl}{2} \right)} \]

If the cavity is perturbed by the insertion of a thin dielectric slab into the middle slot, as shown in Figure 5, the resonant frequency changes. The perturbation method assumes that actual fields with a small perturbation are not greatly different from those of the unperturbed cavity. From the perturbation method, we have

\[ \frac{f_0 - f}{f_0} = \frac{(\varepsilon_r - 1) \varepsilon_0 t}{\varepsilon_0 t \int_0^a \int_0^b |E_0|^2 dx dy} \]

where, \( \varepsilon_r \) and \( t \) are the permittivity and thickness of the inserted thin dielectric slab, respectively; \( E_0 \) and \( W \) are the unperturbed field and total stored energy, respectively; and \( f_0 \) and \( f \) are the unperturbed and perturbed resonant frequency, respectively. Using (7) and (9) in (11) gives

\[ \varepsilon_r = \frac{(f_0 - f)}{f_0 t} + 1 \]

Figure 5. Top view of the cavity loaded with the material under test.
With the perturbation, the total quality factor $Q_0$ is reduced due to the dielectric loss, and becomes the loaded quality factor $Q_L$. The power dissipated in the dielectric is

$$P_d = \frac{\omega \varepsilon_r \varepsilon_0 \tan \delta}{2} \int_0^a \int_0^b |E_0|^2 \, dx \, dy = \frac{\omega^3 \varepsilon_r \varepsilon_0 \mu_0 m^2 \pi^2 b \tan \delta}{4k_0^2 a}$$  \hspace{1em} (13)

The perturbation method also assumes that the $Q_c$ of the cavity does not change. Therefore, we have

$$\frac{1}{Q_L} = \frac{1}{Q_c} + \frac{1}{Q_d}$$  \hspace{1em} (14)

where, $Q_c$ is the same as (10). The dielectric quality factor $Q_d$ is

$$Q_d = \frac{\omega W}{P_d} = \frac{1}{2\varepsilon_r l \tan \delta}$$  \hspace{1em} (15)

2.3. Rigorous Iterative Complex Permittivity Determination

The permittivity $\varepsilon_r$ and loss tangent $\tan \delta$ calculated as (12) and (15) are based on the perturbation method with some approximation. To obtain exact results, the rigorous field analysis is needed.

The total fields in the first half part of the cavity for the TE$_{m0p}$ mode loaded with a thin dielectric slab with the permittivity $\varepsilon_r$ and the thickness $t$ into the middle slot can be written as

$$E_x = 0$$
$$E_y = \frac{\omega \mu_0 m \pi}{k_0 a} \sin \frac{m \pi x}{a} \left\{ A \sin \beta_0 z, \quad 0 < z < (l-t)/2 \right\}$$
$$E_z = \frac{\omega \mu_0 m \pi}{k_0 a} \sin \frac{m \pi x}{a} \left\{ B \cos \beta_1 (l/2 - z), \quad (l-t)/2 < z < l/2 \right\}$$
$$H_x = \frac{m \pi}{k_0 a} \sin \frac{m \pi x}{a} \left\{ A \beta_0 \cos \beta_0 z, \quad 0 < z < (l-t)/2 \right\}$$
$$H_y = \frac{m \pi}{k_0 a} \sin \frac{m \pi x}{a} \left\{ B \beta_1 \sin \beta_1 (l/2 - z), \quad (l-t)/2 < z < l/2 \right\}$$
$$H_z = j \cos \frac{m \pi x}{a} \left\{ A \sin \beta_0 z, \quad 0 < z < (l-t)/2 \right\}$$
$$H_x = j \cos \frac{m \pi x}{a} \left\{ B \cos \beta_1 (l/2 - z), \quad (l-t)/2 < z < l/2 \right\}$$

where $\beta_0$ and $\beta_1$ are the propagation constants in air and dielectric, respectively.

With the boundary condition that $E_y$ and $H_x$ should be continuous across the air-dielectric interface, we have

$$\beta_1 \tan \beta_0 \frac{l-t}{2} = \beta_0 \cot \beta_1 \frac{l}{2}$$  \hspace{1em} (17)

The characteristic Equation (17) is a transcendental equation which can be solved numerically, such as the Newton method or the steepest descent method.

Using (14), we have the total stored energy of the loaded cavity, the conductor loss, and the dielectric loss as

$$W = \varepsilon_0 \int_0^a \int_0^b \int_0^{(l-t)/2} |E_y|^2 \, dx \, dy \, dz + \varepsilon_0 \varepsilon_r \int_0^a \int_0^b \int_0^{(l-t)/2} |E_g|^2 \, dx \, dy \, dz$$

$$= \frac{\varepsilon_0 \omega^2 \mu_0 m^2 \pi^2 b}{2k_0 a} \left\{ \frac{A^2}{2} \left( \frac{l-t}{2} - \frac{\sin \beta_0 (l-t)}{2 \beta_0} \right) + \frac{B^2}{2} \left( \frac{l}{2} + \frac{\sin \beta_1 l}{2 \beta_1} \right) \right\}$$  \hspace{1em} (18)
walls are aluminum alloy with conductivity of \(3.8 \times 10^7\) S/m. The thickness of the material under test is 10 mm.

The interference modes marked with ‘x’ are TM\(_{101}\), TM\(_{103}\), TE\(_{101}\), TE\(_{201}\), TE\(_{105}\), and TE\(_{205}\), in the order of the frequency increasement. The interference modes marked with ‘\(\times\)’ are TM\(_{111}\), TM\(_{131}\), TM\(_{211}\), TM\(_{231}\), TM\(_{151}\), and TM\(_{112}\), in the order of the frequency increasement. In the simulation model, the cavity walls are aluminum alloy with conductivity of \(3.8 \times 10^7\) S/m.

The electric field of all six measurement modes in the area of the middle slot of the rectangular cavity is in \(y\)-axis. The relative permittivity tensor of uniaxially anisotropic materials set in the simulation model is

\[
\tilde{\varepsilon} = \begin{bmatrix}
\varepsilon_{r||} & 0 & 0 \\
0 & \varepsilon_{r\perp} & 0 \\
0 & 0 & \varepsilon_{r\perp}
\end{bmatrix} = (1 - j0.0002) \begin{bmatrix}
4 & 0 & 0 \\
0 & 2.1 & 0 \\
0 & 0 & 2.1
\end{bmatrix}
\] (22)

The cavity only responds to the permittivity tensor component that is parallel with \(y\)-axis, namely, electric field. In the simulation, the axis of the material under test is firstly set in \(y\)-axis. The cavity senses a material with permittivity of 4. Then, the axis of the material under test is set in \(x\)-axis. The cavity senses a material with permittivity of 2.1. The thickness of the material under test is 10 mm.

The cavity only responds to the permittivity tensor component that is parallel with \(y\)-axis, namely, electric field. In the simulation, the axis of the material under test is firstly set in \(y\)-axis. The cavity senses a material with permittivity of 4. Then, the axis of the material under test is set in \(x\)-axis. The cavity senses a material with permittivity of 2.1. The thickness of the material under test is 10 mm.

If the resonant frequency of the loaded cavity \(f\), the permittivity of the material under test \(\varepsilon_r\), and the conductivity of the metallic walls \(\sigma\) are known, the total stored energy \(W\) and the conductor loss \(P_c\) can be calculated with (18) and (19), respectively. Consequentially, the dielectric loss \(P_d\) can be calculated from (21), and then the loss tangent of the material under test \(\tan\delta\) from (20), as long as the loaded quality factor \(Q_L\) is obtained.

3. Simulation

The measurement setup is simulated with the help of an independent software Ansoft HFSS which is basically a numerical 3-D electromagnetic field simulator based on the finite element method. The purpose of the simulation is to confirm the accuracy of the proposed method for calculating uniaxial isotropic permittivity from transmission coefficient data.

The simulated transmission coefficient in the band of 300 MHz to 1100 MHz is shown in Figure 6. The modes used for the permittivity measurement being marked with ‘o’ are TE\(_{101}\), TE\(_{103}\), TE\(_{201}\), TE\(_{203}\), TE\(_{105}\), and TE\(_{205}\), in the order of the frequency increasement. The interference modes marked with ‘\(\times\)’ are TM\(_{111}\), TM\(_{131}\), TM\(_{211}\), TM\(_{231}\), TM\(_{151}\), and TM\(_{112}\), in the order of the frequency increasement. In the simulation model, the cavity walls are aluminum alloy with conductivity of \(3.8 \times 10^7\) S/m.

The electric field of all six measurement modes in the area of the middle slot of the rectangular cavity is in \(y\)-axis. The relative permittivity tensor of uniaxially anisotropic materials set in the simulation model is

\[
\tilde{\varepsilon} = \begin{bmatrix}
\varepsilon_{r||} & 0 & 0 \\
0 & \varepsilon_{r\perp} & 0 \\
0 & 0 & \varepsilon_{r\perp}
\end{bmatrix} = (1 - j0.0002) \begin{bmatrix}
4 & 0 & 0 \\
0 & 2.1 & 0 \\
0 & 0 & 2.1
\end{bmatrix}
\] (22)

The cavity only responds to the permittivity tensor component that is parallel with \(y\)-axis, namely, electric field. In the simulation, the axis of the material under test is firstly set in \(y\)-axis. The cavity senses a material with permittivity of 4. Then, the axis of the material under test is set in \(x\)-axis. The cavity senses a material with permittivity of 2.1. The thickness of the material under test is 10 mm.
Figure 6. Simulated transmission coefficient of the empty cavity. Measurement modes are marked with ‘o’, while interference modes ‘x’.

The calculated results are shown in Table 1. The permittivity $\varepsilon_r$ and the loss tangent $\tan\delta$ are calculated from the transmission coefficient data by two methods. They are the perturbation method and the rigorous iterative method provided in Section 2.2 and 2.3, respectively. The results of the perturbation method are used as initial values for the rigorous iterative method. In this paper, only the results of the rigorous iterative method are given in Table 1. The modeled complex permittivity for the parallel (∥) and perpendicular (⊥) components are set as (22). The modeled and extracted results by the rigorous iterative method are in great agreement.

<table>
<thead>
<tr>
<th>Empty freq (MHz)</th>
<th>TE$_{101}^l$</th>
<th>TE$_{103}^l$</th>
<th>TE$_{201}^l$</th>
<th>TE$_{203}^l$</th>
<th>TE$_{105}^l$</th>
<th>TE$_{205}^l$</th>
</tr>
</thead>
<tbody>
<tr>
<td>Empty Q-factor</td>
<td>345</td>
<td>564</td>
<td>634</td>
<td>775</td>
<td>846</td>
<td>999</td>
</tr>
<tr>
<td>Loaded freq (MHz)</td>
<td>334</td>
<td>547</td>
<td>611</td>
<td>753</td>
<td>821</td>
<td>971</td>
</tr>
<tr>
<td>Loaded Q-factor</td>
<td>19,768</td>
<td>27,040</td>
<td>20,492</td>
<td>28,806</td>
<td>31,549</td>
<td>31,836</td>
</tr>
<tr>
<td>$\varepsilon_r$</td>
<td>3.98</td>
<td>3.96</td>
<td>3.99</td>
<td>3.98</td>
<td>3.96</td>
<td>3.96</td>
</tr>
<tr>
<td>$\tan\delta$</td>
<td>0.00020</td>
<td>0.00020</td>
<td>0.00020</td>
<td>0.00020</td>
<td>0.00019</td>
<td>0.00021</td>
</tr>
</tbody>
</table>

<table>
<thead>
<tr>
<th>Loaded freq (MHz)</th>
<th>TE$_{101}^l$</th>
<th>TE$_{103}^l$</th>
<th>TE$_{201}^l$</th>
<th>TE$_{203}^l$</th>
<th>TE$_{105}^l$</th>
<th>TE$_{205}^l$</th>
</tr>
</thead>
<tbody>
<tr>
<td>Loaded Q-factor</td>
<td>24,184</td>
<td>33,744</td>
<td>29,417</td>
<td>35,045</td>
<td>40,218</td>
<td>42,320</td>
</tr>
<tr>
<td>$\varepsilon_r$</td>
<td>2.09</td>
<td>2.09</td>
<td>2.10</td>
<td>2.09</td>
<td>2.09</td>
<td>2.09</td>
</tr>
<tr>
<td>$\tan\delta$</td>
<td>0.00020</td>
<td>0.00020</td>
<td>0.00020</td>
<td>0.00020</td>
<td>0.00018</td>
<td>0.00019</td>
</tr>
</tbody>
</table>

4. Measurement

After validating the proposed algorithm against the simulated data, an appropriate experimental setup is established in order to facilitate the measurement of transmission coefficient data. The Anritsu MS46322B Vector Network Analyzer (VNA) is used to obtain the transmission coefficient. The sweep parameters of the VNA are set as 201 points and 30 kHz IFBW. Due to the difficulty in producing samples with known anisotropic dielectric properties, the validity of the proposed method is demonstrated by measuring the permittivity of polytetrafluoroethylene (PTFE).

The fabricated multi-mode split rectangular cavity is shown in Figure 7. The cavity is made of aluminum alloy. Several aluminum alloy plates are screwed together to form the cavity. The inner side of the cavity is coated with silver. The inner conductor of the connector extrudes 8 mm into the cavity to act as the feeding pin. The coaxial line used to connect the VNA ports to the feeding pins does not have to be phase-stable cable. No amplifier is used. The transmission coefficient data of the empty and loaded cavity are
measured, and they are shown in Figure 8. The loading material under test is a sheet of PTFE with a thickness of 10 mm. It can be seen that the measured result in Figure 8a is similar to the simulated result in Figure 6.

Figure 7. Photograph of the fabricated cavity with the sample under test.

Figure 8. Simulated transmission coefficient of the cavity: (a) empty and (b) loaded. Measurement modes are marked with ‘o’, while interference modes are marked with ‘x’.
The permittivity $\varepsilon_r$ and the loss tangent $\tan\delta$ are calculated from the measured data in the same way as from the simulated data. The results given in Table 2 correspond to these known properties of PTFE ($\varepsilon_r = 2.06$, $\tan\delta = 2 \times 10^{-3}$) [44]. The variations of the measured permittivity $\varepsilon_r$ and the loss tangent $\tan\delta$ are less than 1% and $1 \times 10^{-5}$, respectively, among all six modes.

Table 2. Calculated results from measurement data.

<table>
<thead>
<tr>
<th>Mode</th>
<th>$\varepsilon_r$</th>
<th>$\tan\delta$</th>
</tr>
</thead>
<tbody>
<tr>
<td>TE$_{101}$</td>
<td>2.04</td>
<td>0.00019</td>
</tr>
<tr>
<td>TE$_{103}$</td>
<td>2.04</td>
<td>0.00019</td>
</tr>
<tr>
<td>TE$_{201}$</td>
<td>2.06</td>
<td>0.00021</td>
</tr>
<tr>
<td>TE$_{203}$</td>
<td>2.05</td>
<td>0.00019</td>
</tr>
<tr>
<td>TE$_{105}$</td>
<td>2.04</td>
<td>0.00020</td>
</tr>
<tr>
<td>TE$_{205}$</td>
<td>2.05</td>
<td>0.00019</td>
</tr>
</tbody>
</table>

5. Conclusions

In this paper, a multi-mode split cavity is designed and fabricated. A large number of interference modes are suppressed by the introduction of extra slots and deliberate choice of feed positions. Complex permittivity measurements of low-loss anisotropic materials are realized by using this cavity at hundreds of megahertz for the first time. The perturbation method and the rigorous iterative method are provided to calculate the permittivity from transmission coefficient. The validity and high precision of the method are demonstrated by simulation and measurement data. The cavity performance verifies its application in the complex permittivity measurement of low-loss cellular materials at hundreds of megahertz.

Author Contributions: Conceptualization, C.L. and C.W.; methodology, C.W.; validation, L.S.; writing—original draft preparation, C.W.; writing—review and editing, C.L. All authors have read and agreed to the published version of the manuscript.

Funding: This research received no external funding.

Conflicts of Interest: The authors declare no conflict of interest.

References


